

RoHS

COMPLIANT

# **FR210ATF-VB** Datasheet

N-Channel 200 V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	200				
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = 10 V 0.85				
Q <sub>g</sub> (Max.) (nC)	13				
Q <sub>gs</sub> (nC)	3.0				
Q <sub>gd</sub> (nC)	7.9				
Configuration	Single				

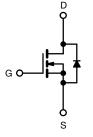
#### **FEATURES**

- Trench Power MOSFET ٠
- 175 °C Junction Temperature ٠
- **PWM Optimized**
- 100 % Rg Tested •
- Compliant to RoHS Directive 2002/95/EC

#### **APPLICATIONS**

• Primary Side Switch





N-Channel MOSFET

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V <sub>DS</sub>	200	- V	
Gate-Source Voltage			V <sub>GS</sub>	± 20		
Continuous Drain Current	$V_{GS}$ at 10 V $T_C = 25 \degree C$		5.0			
Continuous Drain Current	V <sub>GS</sub> at 10 V	$T_{C} = 25 \text{ °C}$ $T_{C} = 100 \text{ °C}$	ID	4.0	А	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	20		
Linear Derating Factor			0.33	0.33	W/°C	
Linear Derating Factor (PCB Mount) <sup>e</sup>				0.020		
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	161	mJ	
Repetitive Avalanche Current <sup>a</sup>			I <sub>AR</sub>	4.8	А	
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	4.2	mJ	
Maximum Power Dissipation	T <sub>C</sub> = 25 °C		D	42	w	
Maximum Power Dissipation (PCB mount) e	T <sub>A</sub> = 25 °C		P <sub>D</sub> 2.5		VV	
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	5.0	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	*	
Soldering Recommendations (Peak temperature) d	for 10 s			260		

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b.  $V_{DD} = 50 \text{ V}$ , starting  $T_J = 25 \text{ °C}$ , L = 14 mH,  $R_g = 25 \Omega$ ,  $I_{AS} = 4.8 \text{ A}$  (see fig. 12). c.  $I_{SD} \leq 5.2 \text{ A}$ , dI/dt  $\leq 95 \text{ A/}\mu$ s,  $V_{DD} \leq V_{DS}$ ,  $T_J \leq 150 \text{ °C}$ .

d. 1.6 mm from case.

e. When mounted on 1" square PCB (FR-4 or G-10 material).



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	-	110	
Maximum Junction-to-Ambient (PCB mount) <sup>a</sup>	R <sub>thJA</sub>	-	-	50	°C/W
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	-	3.0	

Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static		-					<b>I</b>
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA		200	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	Reference to 25 °C, $I_D = 1 \text{ mA}$		0.29	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> = 250 μΑ	2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>		$V_{GS} = \pm 20 \text{ V}$		-	± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>		$V_{DS} = 200 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$ $V_{DS} = 160 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 125 ^{\circ}\text{C}$		-	25 250	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 2.9 A <sup>b</sup>	-	0.85	-	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> =	= 50 V, I <sub>D</sub> = 2.9 A <sup>b</sup>	1.7	-	-	S
Dynamic		-					1
Input Capacitance	C <sub>iss</sub>		$V_{GS} = 0 V,$		185	-	
Output Capacitance	Coss		$V_{DS} = 25 V,$	-	100	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1	.0 MHz, see fig. 5	-	30	-	
Total Gate Charge	Qg			-	-	13.0	
Gate-Source Charge	Q <sub>gs</sub>	$V_{GS} = 10 V$	V $I_D = 4.8 \text{ A}, V_{DS} = 160 \text{ V},$ see fig. 6 and 13 <sup>b</sup>		-	3.0	nC
Gate-Drain Charge	Q <sub>gd</sub>		see lig. o and to	-	-	7.9	1
Turn-On Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = 100 V, I <sub>D</sub> = 4.8 A,		-	7.2	-	- ns
Rise Time	t <sub>r</sub>			-	22	-	
Turn-Off Delay Time	t <sub>d(off)</sub>	R <sub>G</sub> = 18 Ω,	$R_G$ = 18 $\Omega$ , $R_D$ = 20 $\Omega$ , see fig. 10 <sup>b</sup>		19	-	
Fall Time	t <sub>f</sub>			-	13	-	
Internal Drain Inductance	L <sub>D</sub>	6 mm (0.25")	Between lead, 6 mm (0.25") from package and center of die contact		4.5	-	
Internal Source Inductance	L <sub>S</sub>	1 0			7.5	-	- nH
Drain-Source Body Diode Characteristic	s	•					•
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	4.8	^
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	19	A
Body Diode Voltage	V <sub>SD</sub>	$T_J$ = 25 °C, $I_S$ = 4.8 A, $V_{GS}$ = 0 V <sup>b</sup>		-	-	1.8	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	$T_{\rm J} = 25 ^{\circ}\text{C}, I_{\rm F} = 4.8 \text{A}, \text{dl/dt} = 100 \text{A/}\mu\text{s}^{\text{b}}$		-	150	300	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	0.91	1.8	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic tu	ırn-on time is negligible (turn	-on is dor	ninated b	y L <sub>S</sub> and	L <sub>D</sub> )

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width  $\leq$  300  $\mu$ s; duty cycle  $\leq$  2 %.



#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

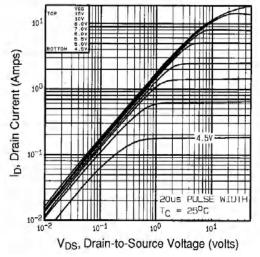


Fig. 1 - Typical Output Characteristics,  $T_C = 25 \ ^{\circ}C$ 

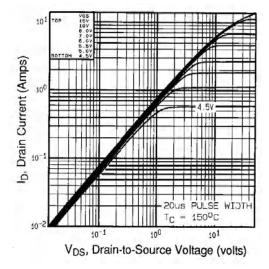


Fig. 2 - Typical Output Characteristics,  $T_C = 150$  °C

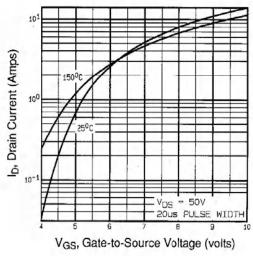


Fig. 3 - Typical Transfer Characteristics

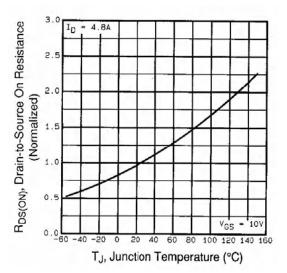


Fig. 4 - Normalized On-Resistance vs. Temperature



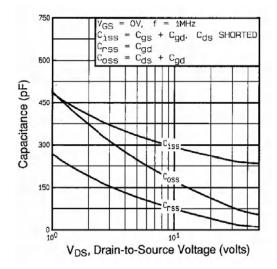


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

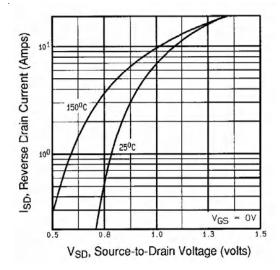


Fig. 7 - Typical Source-Drain Diode Forward Voltage

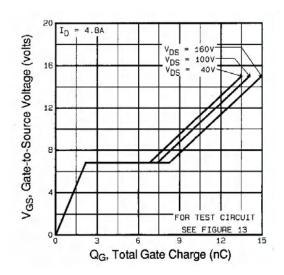


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

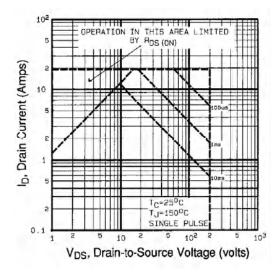


Fig. 8 - Maximum Safe Operating Area



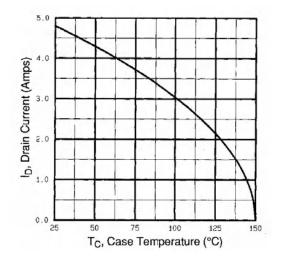


Fig. 9 - Maximum Drain Current vs. Case Temperature

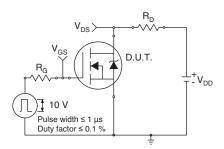


Fig. 10a - Switching Time Test Circuit

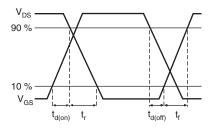


Fig. 10b - Switching Time Waveforms

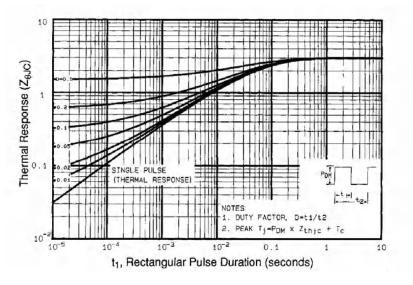


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



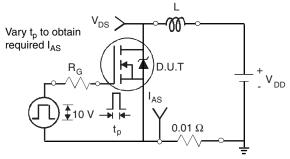


Fig. 12a - Unclamped Inductive Test Circuit

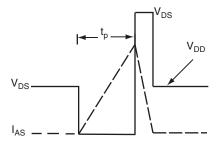


Fig. 12b - Unclamped Inductive Waveforms

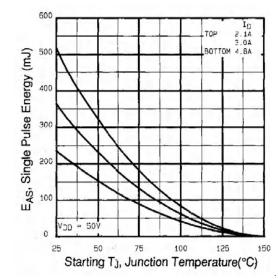


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

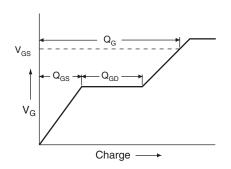


Fig. 13a - Basic Gate Charge Waveform

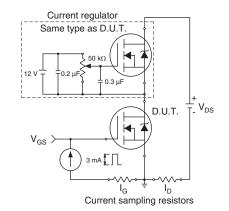
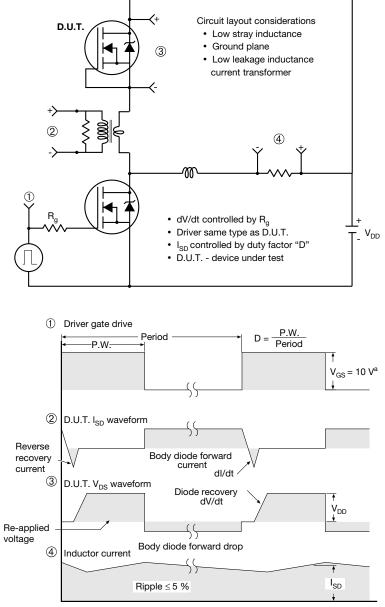


Fig. 13b - Gate Charge Test Circuit



#### Peak Diode Recovery dV/dt Test Circuit

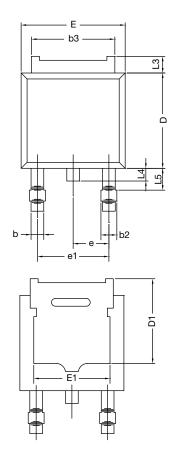


Note

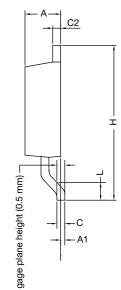
a.  $V_{GS}$  = 5 V for logic level devices

Fig. 14 - For N-Channel





## **TO-252AA Case Outline**



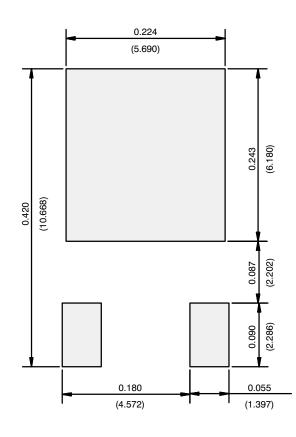
	MILLIN	IETERS	INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.	
А	2.18	2.38	0.086	0.094	
A1	-	0.127	-	0.005	
b	0.64	0.88	0.025	0.035	
b2	0.76	1.14	0.030	0.045	
b3	4.95	5.46	0.195	0.215	
С	0.46	0.61	0.018	0.024	
C2	0.46	0.89	0.018	0.035	
D	5.97	6.22	0.235	0.245	
D1	4.10	-	0.161	-	
Е	6.35	6.73	0.250	0.265	
E1	4.32	-	0.170	-	
Н	9.40	10.41	0.370	0.410	
е	2.28	BSC	0.090 BSC		
e1	4.56	4.56 BSC		0.180 BSC	
L	1.40	1.78	0.055	0.070	
L3	0.89	1.27	0.035	0.050	
L4	-	1.02	-	0.040	
L5	1.01	1.52	0.040	0.060	
ECN: T16- DWG: 534	0236-Rev. P, <sup>-</sup> 7	16-May-16			

Notes

• Dimension L3 is for reference only.



#### **RECOMMENDED MINIMUM PADS FOR DPAK (TO-252)**



Recommended Minimum Pads Dimensions in Inches/(mm)



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